Sheet 1 of 1		DIPE			Page	lof
FORM PTO 1449 (modified)		JUL 2 0 2001	35.C9339 CII/DI	ET NO. 5.C9339 CII/DI DIVISIONAL OF APPLICATION NO. 08/906,107		
PATE	DEPARTMENT OF COMMERCE INT AND TRADEMARK OFFICE	ì	TOSHIMI IIZUKA			
LIST OF RE (Us	FERENCES CITED BY APPLICAN se several sheets if necessary)	PADEMARKE	FILING DATE		GROUP INF	
Date Submitted to PTO:	April 11, 2001		April 11, 2001			2872
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
NG)	3,503,663	03/31/70	DE LA CIERVA, ET AL.	.358 ³⁵⁹	287	
NO	3,608,995	09/28/71	HUMPHREY	350 ³⁵⁹	557 36	
MC)	3,942,862	03/09/76	FURUKAWA, ET AL.	350%	5576	
NG)	4,013,339	03/22/77	ANDO, ET AL.	- 350 ³⁵⁹	556 18	
WY	4,063,261	12/13/77	KUBOSHIMA	354 396		
UE)	5,042,930	08/27/91	HUTT	359	407375	
DE	5,140,462	08/18/92	KITAGISHI	359	SS 2554	
DG)	5,182,671	01/26/93	KITAGISHI, ET AL.	359	557	
Nen	5,311,367	05/10/94	OHKI, ET AL.	359	832	
NE	5,315,435	05/24/94	HORIUCHI	359	554	
Nen	5,661,597	08/26/97	SUGAWARA	359	362	
NET	5,672,862	09/30/97	OHARA, ET AL.	250	204	
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
Da	50-5058	01/20/75	JAPAN			NO
180	205,621	11/13/67	RUSSIA			- NO
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
NAAR						
EXAMINER DATE CONSIDERED 2/26/02 SONITS						
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy						
*EXAMINER: Initial if reference considered, whether or not station is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. CPWInt DC. MAIN 55448 v 1						
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DC_MAIN 55448 v 1						
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